Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/560,347	YAMADA ET AL.	
Examiner	Art Unit	
Hae M. Hyeon	2839	

SEARCHED					
Class	Subclass	Date	Examiner		
Search	Updated	7/01	honh		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
439	91	7/01	hmh		
439	591	V	V		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Interference Text Search Done	1/01	hmh		
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